

Notice of References Cited	Application/Control No. 09/604,315	Applicant(s)/Patent Under Reexamination MIYA ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,333,934 B1	12-2001	Miura	370/441
*	B	US-6,430,166 B1	08-2002	Bejjani et al.	370/320
*	C	US-6,269,075 B1	07-2001	Tran	370/206
*	D	US-6,314,127 B1	11-2001	Lynch et al.	375/144
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